Power MOSFET

30 V, 171 A, Single N-Channel, SO-8 FL

Features

- Low R_{DS(on)} to Minimize Conduction Losses
- Low Capacitance to Minimize Driver Losses
- Includes Schottky Diode
- Optimized Gate Charge to Minimize Switching Losses
- Dual Sided Cooling Capability
- These are Pb-Free Device

Applications

- CPU Power Delivery
- DC-DC Converters
- Low Side Switching

MAXIMUM RATINGS (T_J = 25°C unless otherwise stated)

Par	Symbol	Value	Unit		
Drain-to-Source Voltage			V_{DSS}	30	V
Gate-to-Source Voltage			V_{GS}	±20	V
Continuous Drain Current R _{0JA} (Note 1)		$T_A = 25^{\circ}C$ $T_A = 85^{\circ}C$	Ι _D	29 21	A
Power Dissipation R _{θJA} (Note 1)		T _A = 25°C	P _D	2.74	W
Continuous Drain Current R _{θJA} ≤ 10 sec		T _A = 25°C T _A = 85°C	Ι _D	47 34	A
Power Dissipation $R_{\theta JA,} t \leq 10 \text{ sec}$	Steady	T _A = 25°C	P _D	7.3	W
Continuous Drain Current R _{0JA} (Note 2)	State	$T_A = 25^{\circ}C$ $T_A = 85^{\circ}C$	Ι _D	17 12	Α
Power Dissipation R _{θJA} (Note 2)		T _A = 25°C	P _D	0.95	W
Continuous Drain Current R _{0JC} (Note 1)		$T_C = 25^{\circ}C$ $T_C = 85^{\circ}C$	Ι _D	171 123	Α
Power Dissipation $R_{\theta JC}$ (Note 1)		T _C = 25°C	P _D	96.2	W
Pulsed Drain Current	t _p =10μs	T _A = 25°C	I _{DM}	288	Α
Current limited by pa	ackage	T _A = 25°C	I _{Dmaxpkg}	100	Α
Operating Junction and Storage Temperature			T _J , T _{STG}	-40 to +150	°C
Source Current (Body Diode)			I _S	120	Α
Drain to Source dV/dt			dV/dt	6	V/ns
Single Pulse Drain-to-Source Avalanche Energy (V_{DD} = 50 V, V_{GS} = 10 V, I_L = 50 A_{pk} , L = 0.3 mH, R_G = 25 Ω)			EAS	375	mJ
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)			TL	260	°C

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

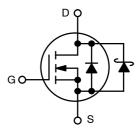


ON Semiconductor®

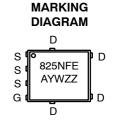
http://onsemi.com

V _{(BR)DSS}	R _{DS(ON)} MAX	I _D MAX
30 V	2.0 mΩ @ 10 V	171 A
	3.0 mΩ @ 4.5 V	140 A

N-CHANNEL MOSFET







A = Assembly Location

Y = Year
W = Work Week
ZZ = Lot Traceability

ORDERING INFORMATION

Device	Package	Shipping [†]
NTMFS4825NFET1G	SO-8FL (Pb-Free)	1500 / Tape & Reel
NTMFS4825NFET3G	SO-8FL (Pb-Free)	5000 / Tape & Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Case (Drain)	$R_{\theta JC}$	1.3	
Junction-to-Ambient - Steady State (Note 1)	$R_{\theta JA}$	45.7	
Junction-to-Ambient - Steady State (Note 2)	$R_{\theta JA}$	132.1	°C/W
Junction-to-Ambient - t ≤ 10 sec	$R_{\theta JA}$	17.2	
Junction-to-Top	$R_{ heta JT}$	7.0	

- 1. Surface-mounted on FR4 board using 1 sq-in pad, 1 oz Cu.
- 2. Surface-mounted on FR4 board using the minimum recommended pad size.

ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise specified)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS					•		
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	V _{GS} = 0 V, I _D = 1.0 mA		30			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V _{(BR)DSS} /				28.5		mV/°C
Zero Gate Voltage Drain Current	I _{DSS}	V _{GS} = 0 V, V _{DS} = 24 V	T _J = 25 °C		60	500	μΑ
Gate-to-Source Leakage Current	I _{GSS}	V _{DS} = 0 V, V _{GS} = ±20 V				±100	nA
ON CHARACTERISTICS (Note 3)							
Gate Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}, I_D =$	= 1.0 mA	1.5	2.0	2.5	V
Negative Threshold Temperature Coefficient	V _{GS(TH)} /T _J				4		mV/°C
Drain-to-Source On Resistance	R _{DS(on)}	V _{GS} = 10 V	I _D = 22 A		1.3	2.0	
			I _D = 20 A		1.3		_
		V _{GS} = 4.5 V	I _D = 20 A		2.0	3.0	mΩ
			I _D = 18 A		2.0		1
Forward Transconductance	9FS	V _{DS} = 15 V, I _D	= 15 A		90		S
CHARGES AND CAPACITANCES	•						•
Input Capacitance	C _{ISS}	V _{GS} = 0 V, f = 1 MHz, V _{DS} = 15 V			5660		pF
Output Capacitance	C _{OSS}				1150		
Reverse Transfer Capacitance	C _{RSS}				495		
Total Gate Charge	Q _{G(TOT)}				40.2		1
Threshold Gate Charge	Q _{G(TH)}	.,			6.4		1
Gate-to-Source Charge	Q _{GS}	$V_{GS} = 4.5 \text{ V}, V_{DS} = 15 \text{ V}; I_D = 23 \text{ A}$			15.3		nC
Gate-to-Drain Charge	Q_{GD}				13.4		
Total Gate Charge	Q _{G(TOT)}	V _{GS} = 10 V, V _{DS} = 15 V, I _D = 23 A			83.6		nC
SWITCHING CHARACTERISTICS (Note 4)							
Turn-On Delay Time	t _{d(ON)}	V_{GS} = 4.5 V, V_{DS} = 15 V, I_{D} = 15 A, R_{G} = 3.0 Ω			26		ns
Rise Time	t _r				24		
Turn-Off Delay Time	t _{d(OFF)}				36		
Fall Time	t _f				13		

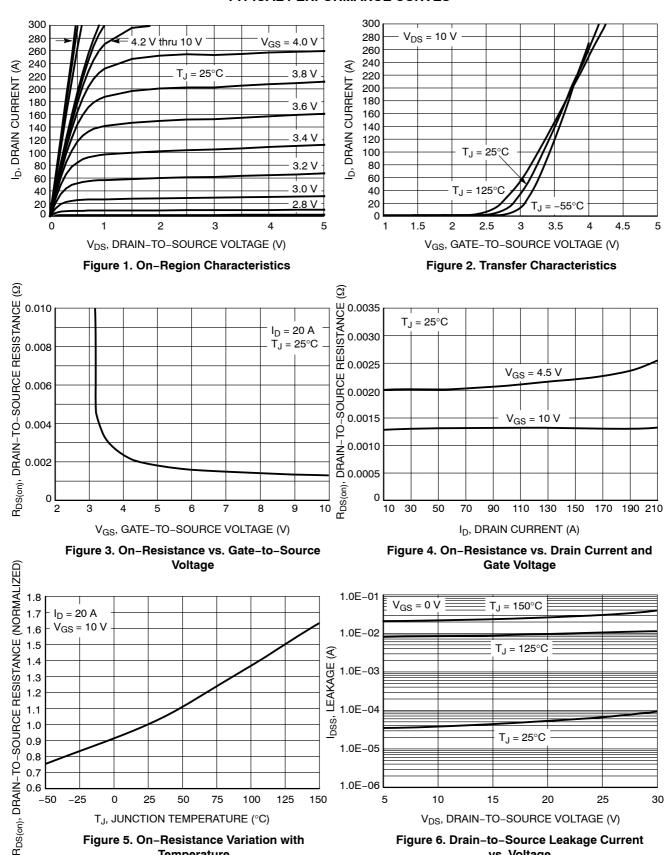
- Pulse Test: pulse width ≤ 300 μs, duty cycle ≤ 2%.
 Switching characteristics are independent of operating junction temperatures.

ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise specified)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
SWITCHING CHARACTERISTICS (N	ote 4)			•	•	•	
Turn-On Delay Time	t _{d(ON)}	V_{GS} = 10 V, V_{DS} = 15 V, I_{D} = 15 A, R_{G} = 3.0 Ω			15.7		- ns
Rise Time	t _r				21.2		
Turn-Off Delay Time	t _{d(OFF)}				44.6		
Fall Time	t _f				14.5		
DRAIN-SOURCE DIODE CHARACTE	ERISTICS						
Forward Diode Voltage	V_{SD}	V _{GS} = 0 V, I _S = 2.0 A	T _J = 25°C		0.35	0.70	
			T _J = 125°C		0.26		V
Reverse Recovery Time	t _{RR}	V _{GS} = 0 V, dI _S /dt = 100 A/μs, I _S = 23 A			39.1		ns
Charge Time	t _a				20.1		
Discharge Time	t _b				19		
Reverse Recovery Charge	Q _{RR}				34		nC
PACKAGE PARASITIC VALUES					-		
Source Inductance	L _S				0.66		nH
Drain Inductance	L _D	T _A = 25°C			0.20		
Gate Inductance	L _G				1.5		
Gate Resistance	R_{G}				0.7	2.0	Ω

Pulse Test: pulse width ≤ 300 μs, duty cycle ≤ 2%.
 Switching characteristics are independent of operating junction temperatures.

TYPICAL PERFORMANCE CURVES



1.0E-06

5

10

15

20

V_{DS}, DRAIN-TO-SOURCE VOLTAGE (V)

Figure 6. Drain-to-Source Leakage Current

vs. Voltage

25

30

0.6

-50

-25

0

25

50

T_J, JUNCTION TEMPERATURE (°C)

Figure 5. On-Resistance Variation with

Temperature

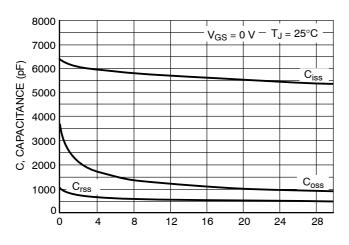
75

100

125

150

TYPICAL PERFORMANCE CURVES



V_{DS}, DRAIN-TO-SOURCE VOLTAGE (V)

Figure 7. Capacitance Variation

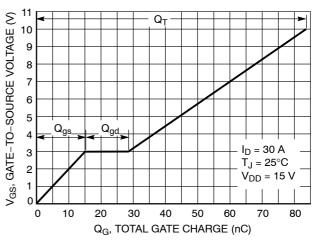


Figure 8. Gate-to-Source and Drain-to-Source Voltage vs. Total Charge

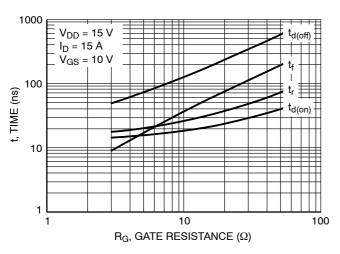


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

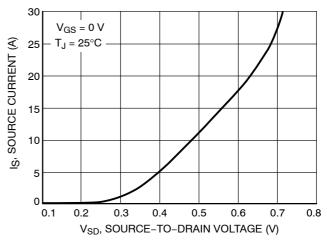


Figure 10. Diode Forward Voltage vs. Current

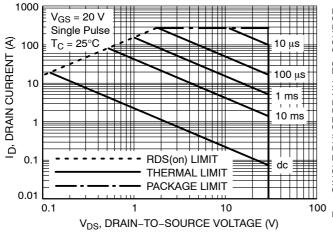


Figure 11. Maximum Rated Forward Biased Safe Operating Area

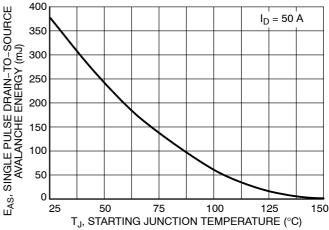


Figure 12. Maximum Avalanche Energy vs. Starting Junction Temperature



0.10

0.10

SIDE VIEW

DFN5 5x6, 1.27P (SO-8FL) CASE 488AA **ISSUE N**

DATE 25 JUN 2018

NOTES

- 1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994. CONTROLLING DIMENSION: MILLIMETER.
- 3. DIMENSION D1 AND E1 DO NOT INCLUDE MOLD FLASH PROTRUSIONS OR GATE BURRS.

	MILLIMETERS				
DIM	MIN	NOM	MAX		
Α	0.90	1.00	1.10		
A1	0.00	-	0.05		
b	0.33	0.41	0.51		
С	0.23	0.28	0.33		
D	5.00	5.15	5.30		
D1	4.70	4.90	5.10		
D2	3.80	4.00	4.20		
E	6.00	6.15	6.30		
E1	5.70	5.90	6.10		
E2	3.45	3.65	3.85		
е	1.27 BSC				
G	0.51	0.575	0.71		
K	1.20	1.35	1.50		
L	0.51	0.575	0.71		
L1	0.125 REF				
M	3.00	3.40	3.80		
θ	0 °		12 °		

GENERIC MARKING DIAGRAM*

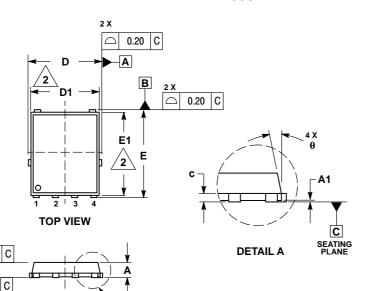


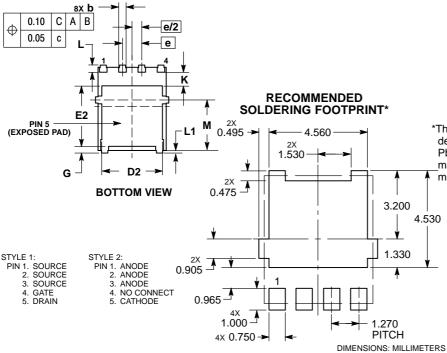
XXXXXX = Specific Device Code

= Assembly Location Α

Υ = Year W = Work Week ZZ = Lot Traceability

*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot " ■", may or may not be present. Some products may not follow the Generic Marking.





DETAIL A

*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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DESCRIPTION:	DFN5 5x6, 1.27P (SO-8FL)		PAGE 1 OF 1	

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